深圳市智诚光电发展有限公司

PRODUCT SPECIFICATIONS

For Customer:
□ : APPROVAL FOR SPECIFICATION

Module No.: ZC043IA01-500

Date:2020.03.03

Version :A

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For Customer's Acceptance:

Approved By	Comment

PREPARED	CHECKED	VERIFIED BY QA DEPT	VERIFIED BY R&D DEPT

深圳市智诚光电发展有限公司

2. Revision Record

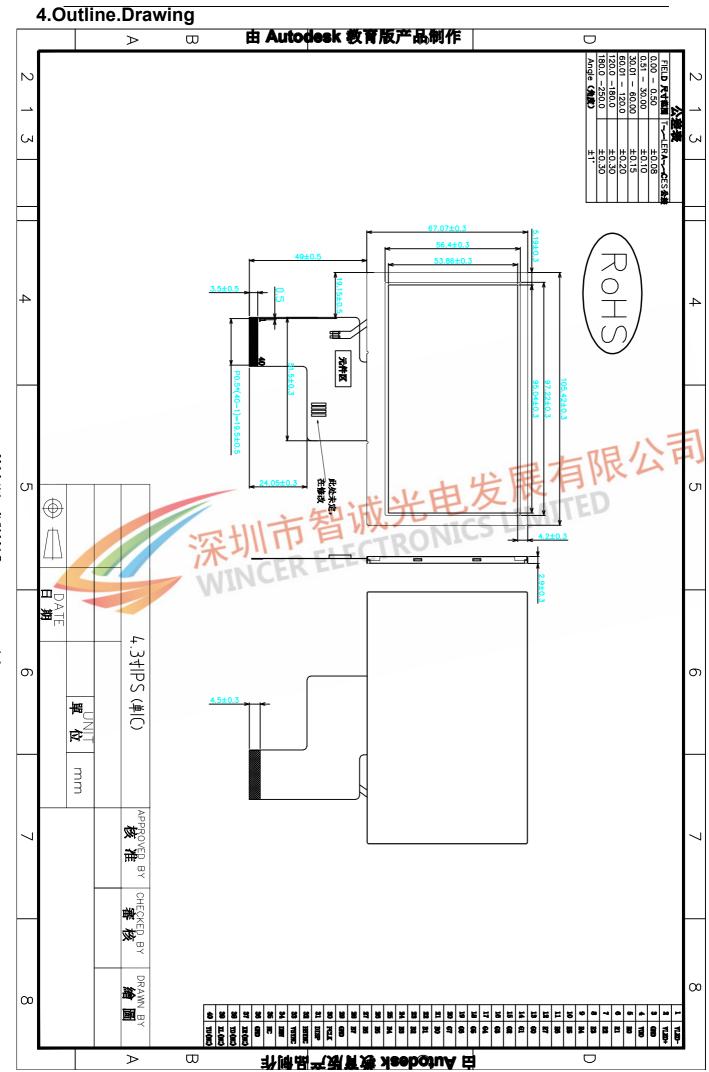
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Date	Rev.No.	Page	Revision Items	Prepared	
2020.03.03					
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3. General Specifications

ZC043IA01-500 isaTFT-LCDmodule.ItiscomposedofaTFT-LCDpanel,driverIC, FPC, a back light unit. The 4.3'' display area contains 800 x 480 pixels and can display up to 16.7M colors. This product accords with RoHS environmental criterion.

Item	Contents	Unit	Note
LCD Type	Normally Black, Transmissive	-	
Display color	16.7M		1
Viewing Direction	ALL	Q' Clock	
Operating temperature	圳市智波光电发	°C)
Storagetemperature	-30~+80	C	
Module Size	105.50(W)*67.20(H)*3.00(T)	ММ	+-0.2
ActiveArea	95.04(W)*53.858(H)	ММ	
Number of Dots	800×RGB×480	dots	
Data Transfer	RGB interface	-	



由 Autodesk 教育版产品制作

5. Absolute Maximum Ratings(Ta=25℃)

Parameter	Symbol	Min	Тур	Max	Unit	Note
	VDD	-0.3	-	3.96	V	
Device events	AVDD	-0.5	-	14.85	V	
Power supply	VGL	-	-10.5	-	V	
	VGH	-	13	-	V	
Operating Temperature	TOP	-G0	-	70	°C	
Storage Temperature	TST	-30	-	85	°C	

5.1 Electrical Absolute Maximum Ratings.(Vss=0V ,Ta=25°C)

If the module is above these absolute maximum ratings. It may become permanently damaged.
 Using the module within the following electrical characteristic conditions are also exceeded, the module will malfunction and cause poor reliability.

- 2. VDD>V_{SS} must be maintained.
- 3. Please be sure users are grounded when handing LCD Module.

5.2 Environmental Absolute Maximum Ratings.

Item	Stor	age	Operat	Note	
	MIN.	MAX.	MIN.	MAX.	
Ambient Temperature	-30 ℃	85 °C	-20 ℃	70 ℃	1,2
Humidity	-	-	-	-	3

6. Electrical Specifications and Timing Characteristics

Parame	Parameter Sy		Condition	Min	Тур	Max	Unit	Note		
Power supply		VDD	Ta=25 ℃	2.8	3.3	3.6	V			
Input	'H'	VIH	VDD=3.3V	0.7VDD	-	VDD	V			
voltage	'L'	VIL	VDD=3.3V	0	-	0.3VDD	V			
Current Consumption		I _{CC1}	Normal mode	-	-	-	mA	2		
		I _{CC2}	Sleep mode	-	0.03	0.09	mA	2		
Note: ID 展有限公司										
1:When an optimum contrast is obtained in transmissive mode.										
	2 Tuble of the state of the CharTED									

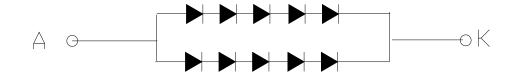
6.1 Electrical characteristics(Vss=0V ,Ta=25°C)

1:When an optimum contrast is obtained in transmissive mode. S LIMI

2: Tested in 1×1 chessboard pattern.

6.2 LED backlight specification(VSS=0V ,Ta=25°C)

Item	Symbol	Condition	Min	Тур	Max	Unit	Note
Supplyvoltage		-	-	15	-	V	
Supply current	l _f	-	-	45	-	MA	



Note:

1: VLED=VLED(+)-VLED(-).

2:The current of LED is 20mA.

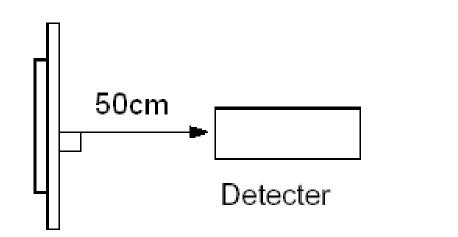
A LED drive in constant current mode is recommended.

6.3 Interface signals

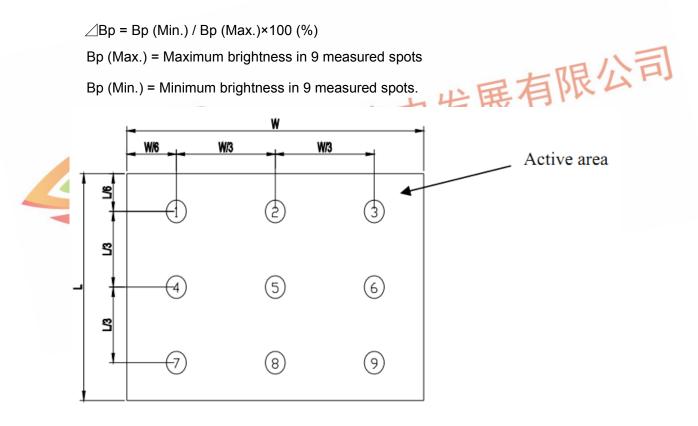
Pin	Symbol	Description.
1	LED_K	Backlight LED Ground
2	LED_A	Backlight LED Power
3	GND	GND
4	VDD	Power supply
5~12	R0-R7	Red data bus
13~20	G0-G7	Green data bus
21~28	B0-B7	Blue data bus
29	GND	GND
30	PCLK	Data clock 看 视 PONICS LIM
31	DISP	Standby mode select pin
32	HSYNC	Line SYNC signal
33	VSYNC	Frame SYNC signal
34	DE	Data Enable Input
35	NC	NC
36	GND	GND
37	X1	Touch Panel Control Pin
38	Y1	Touch Panel Control Pin
39	X2	Touch Panel Control Pin
40	Y2	Touch Panel Control Pin

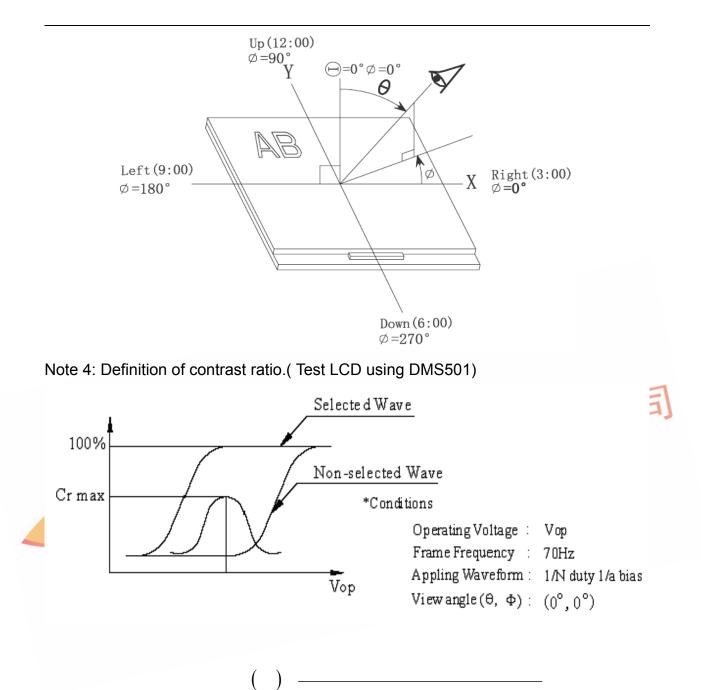
7. Optical Characteristics

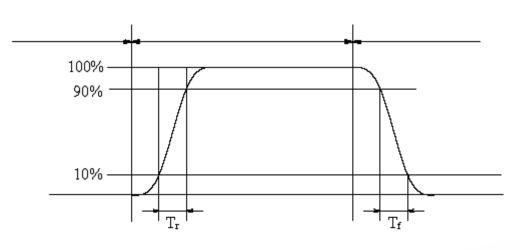
Item	Sy	mbol	Condition	Min.	Тур.	Max.	Unit	Note
Brightness	I	Зр	<i>θ</i> =0°	-		-	Cd/m ²	1
Uniformity		∃Вр	Ф =0°	75	80	-	%	1,2
	3	:00		70	80	-		
Viewing	6	:00	Cr≥10	70	80	-	Dea	2
Angle	9	:00	CI210	70	80	-	Deg	3
	12	2:00		70	80	-		
Contrast Ratio		Cr	<i>θ</i> =0°		1200			
Response Time	$T_r + T_f \Phi = 0^\circ$			30	40	ms	5	
		Х			0.311			
	W				0.388			
		Y		-	-	-		N
	R	x y		1/1	书坊	展	有限	EL.
Color of CIE		Y	七知访	元	HIN C	I TM	TED	
Coordinate	行	-x	Φ=0°	TRO	VICS		-	1,6
	G	y	Φ=0°				-	
		Y		-	-	-		
		X					-	
	В	У					-	
		Y		-	-	-		
NTSC Ratio								



Note 2: The luminance uniformity is calculated by using following formula.

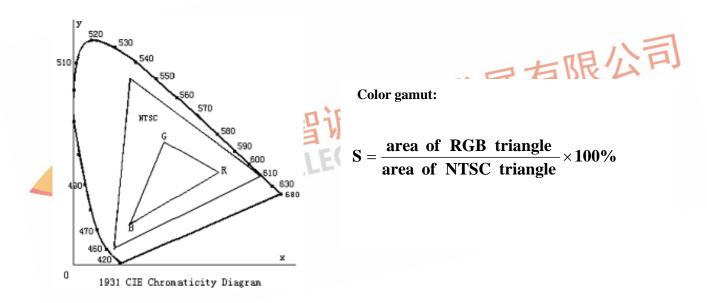






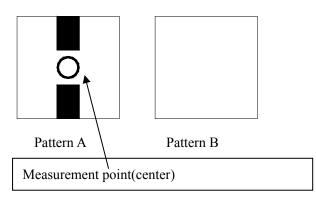
The definition of response time

Note 6: Definition of Color of CIE Coordinate and NTSC Ratio.



Note 7: Definition of cross talk.

Cross talk ratio(%)=|pattern A Brightness-pattern B Brightness|/pattern A Brightness*100



Electric volume value=3F+/-3Hex

8. Reliability Test Items and Criteria

No	Test Item	Test condition	Criterion
1	High Temperature Storage	80℃±2℃ 96 H Restore 2H at 25℃ Power off	
2	Low Temperature Storage	-30℃±2℃ 96H Restore 2H at 25℃ Power off	1 After testing
3	High Temperature Operation	70°C±2°C 96 H Restore 2H at 25°C Power on	1. After testing, cosmetic and electrical defects should not happen.
4	Low Temperature Operation	-20 °C±2°C 96H Restore 4H at 25°C Power on	2. Total current consumption should not be more than twice
5	High Temperature/Humidity Operation	60℃±2℃ 90%RH 96H Power on	of initial value.
6	Temperature Cycle	-20°C → 70°C 30min 5min 30min → 大 示 after 5 cycle, Restore 2H at 25°C Power off	有限公司 ITED
7	Vibration Test	10Hz~150Hz, 100m/s ² , 120min	Not allowed cosmetic
8	Shock Test	Half- sine wave,300m/s ² ,11ms	and electrical defects.
9	ESD Test	Air discharge: \pm 8KV, Contact discharge: \pm 4KV	

Note: Operation: Supply 3.3V for logic system.

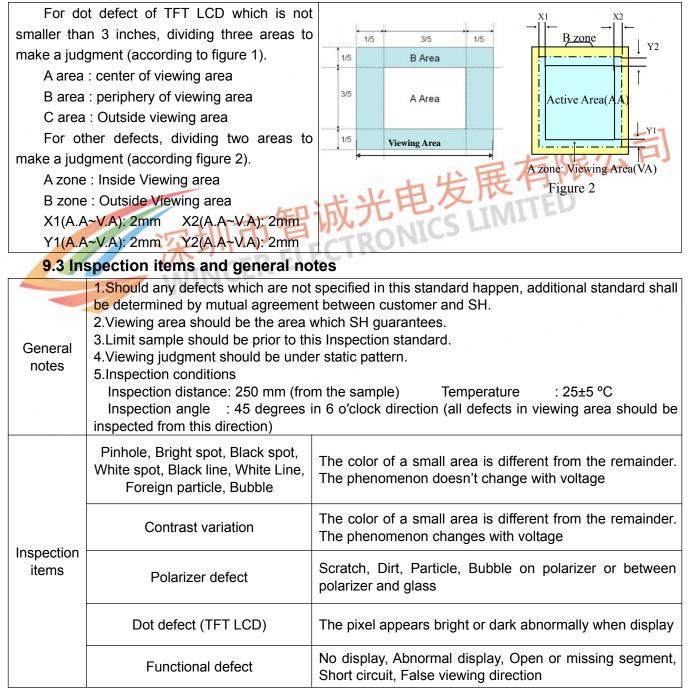
The inspection terms after reliability test, as below

ITEM	Inspection			
Contrast	CR>50%			
IDD	IDD<200%			
Brightness	Brightness>60%			
Color Tone	Color Tone+/-0,05			

degrade usability for product applications, including all functional defects(such as no display, abnormal display, open or missing segment, short circuit, missing component), outline dimension beyond the drawing, progressive defects and those affecting reliability.

Minor defects (MI): A minor defect refers to a defect which is not considered to be able to substantially degrade the product application or a defect that deviates from existing standards almost unrelated to the effective use of the product or its operation, such as black spot, white spot, bright spot, pinhole, black line, white line, contrast variation, glass defect, polarizer defect, etc.

9.2 Definition of inspection range



Glass defect	Glass crack, Shaved corner of glass, Surplus glass
PCB defect	Components assembly defect

9.4 Outgoing Inspection level

Outgoing Inspection	Inspection conditions		Inspection					
standard		Min.	Max.	Unit	IL	AQL		
Major Defects	See 8.5			П	0.065			
Minor Defects	See 8.3 general notes	otes See		5	II	0.065		
Note: Sampling standard conforms to GB2828								

9.5 Inspection Items and Criteria

		Judgment standard				
Inspection items			Category	Acceptable number		
	1				E Azone	B zone
			A	Φ<=0.20	Neglected	Neglected
	Black spot, White spot,	下一下首	в	0.20<Φ<=0.25	3	Neglected
1	Pinhole, Foreign Particle, Particle	a CER EL	С	0.25<Ф<=0.3	2	Neglected
	in or on glass, Scratch on glass	or on glass, $\Phi=(a+b)/2(mm)$		0.3<Ф<=0.4	1	3
	Scraten on glass		Е	0.4<Ф<=0.5	0	2
		(a/b<2.5)		tal defective point(B,C)	1	-
			А	W<=0.03	Neglected	Neglected
	2 Black line, White line, and Particle Between Polarizer and glass, Scratch on glass		В	0.03 <w<=0.05 L<=3.0</w<=0.05 	3	Neglected
2		L:Length(mm)	с	0.05 <w<=0.1 L<=3.0</w<=0.1 	2	Neglected
		L/W>=2.5	D	0.05 <w<=0.1 L<=4.0</w<=0.1 	1	3
	·		W>0.1 L>4.0	0	2	
			Тс	tal defective point(B,C)	1	-
3	Bright spot		any size		none	none
4	Contrast		Α Φ<0.2		Neglected	Neglected

	variation		В	0.2<Ф<=0.3	2		
				0.3<Ф<=0.4	1		
				0.4<Ф	0		
		$\Phi = (a+b)/2(mm)$	То	Total defective point(B,C) 3			
5	Bubble inside cell			any size	none	none	
	Polarizer defect	Scratch ,damage on polarizer, Particle on polarizer or between polarizer and glass.	Refer to item 1 and item 2.				
6	(if Polarizer is used)	Bubble, dent and convex	A	Φ<=0.1	Neglected	Neglected	
			В	0.1 <Ф<=0.2	2	Neglected	
			С	0.2 <Ф<=0.3	1	2	
7	Surplus glass	Stage surplus glass	B<=0.3mm				
8	8 Open segment or open common		Not permitted				
9	Short circuit	rt circuit		Not permitted			
10	False viewing dired	ction	Not permitted				
11	Contrast ratio une	atio uneven		According to the limit specimen			
12	Crosstalk	Crosstalk		According to the limit specimen			
13	Black /White spot(display)		Refer to item 1				
14	Black /White line(d	isplay)	Re	fer to item 2			

Inspection items Judgment standard Category(application: B zone) Acceptable number i) The front of lead terminals A a ≤ t, b≤1/5W, c≤3mm B Crack at two sides of lead terminals should not cover patterns and alignment mark ii) Surrounding crack-non-contact side seal c b defect iii) Surrounding crack-contact side seal defect iii) Surrounding crack contact side seal defect iii) Surrounding crack contact side seal defect iii) Surrounding crack contact side seal b < Inner border line of the seal Max.3 defects allowed liner border line of the seal b < Outer borderline of the seal liner border line of the seal b < Outer borderline of the seal
15 Glass Inner border line of the seal Inner border line of the seal Max.3 15 Glass Inner border line of the seal Inner border line of the seal Max.3
15 Glass ii) Surrounding crack-non-contact side 15 Glass Imer border line of the seal 16 C Imer border line of the seal 17 C Imer border line of the seal 18 C C 19 C Imer border line of the seal 10 C Imer border line of the seal 11 C Imer border line of the seal 12 C Imer border line of the seal 13 C Imer border line of the seal 14 C Imer border line of the seal 15 C Imer border line of the seal 16 C Imer border line of the seal 17 C Imer border line of the seal 18 C Imer border line of the seal 19 C C
15 Glass Imer border line of the seal 16 Crack at two sides of lead terminals should not cover patterns and alignment mark 17 Imer border line of the seal 18 Crack at two sides of lead terminals should not cover patterns and alignment mark 18 Surrounding crack-non-contact side 19 Imer border line of the seal 10 Could be seal 11 Could be seal 12 Class 13 Imer border line of the seal 14 Could be seal 15 Crack 16 Surrounding crack-contact side seal 17 Could be seal 18 Crack 19 Crack 10 Could be seal 11 Could be seal 12 Could be seal 13 Could be seal 14 Could be seal 15 Crack 16 Surround be seal 17 Could be seal 18 Could be seal 19 Could be seal 10 Could be seal 10
iv)Corner A a <= t, b <= 3.0, c <= 3.0

	Inspection items	Judgment standard Category(application: B zone)
16 PCB defect	Component soldering: No cold soldering, short, open circuit, burr, tin ball The flat encapsulation component position deviation must be less than 1/3 width of the pin (Pic.1): the sheet component deviation: Pin deviates from the pad and contact with the near components is not permitted (Pic.2) lead defect: The lead lack must be less than 1/3 of its width; The lead burr must be less than 1/3 of the seam; Impurities connect with the near leads is not permitted Connector soldering: Soldering tin is at contact position of the plug and socket is not permitted No foundation is scald Serious cave distortion on plug and socket contact pin is not permitted	Component Soldering pad Lead Lad Live Lot Live Lot Live Soldering pad Lead Lot Live Soldering pad Lead Lot Live Soldering pad Lead Lot Live Lot Soldering tin is not permit in this area Soldering tin is not permit in this area Soldering tin is not permit in this area Soldering tin is not permit in this area Soldering tin is not permit in this area
	into the PCB; the protected glue must envelop to the insulative coat.	PCB Insulative coat